

STGW50HF60SD

60 A, 600 V, very low drop IGBT with soft and fast recovery diode

Features

- Very low on-state voltage drop
- Low switching off
- High current capability
- Very soft ultra fast recovery antiparallel diode

Application

- PV inverter
- UPS

Description

STGW50HF60SD is a very low drop IGBT based on new advanced planar technology, showing extremely low on-state voltage and limited turn-off losses. The overall performance makes this IGBT ideal in low frequency switches of mixed frequency topologies for PF ≤ 1 .

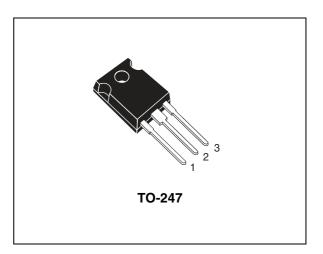


Figure 1. Internal schematic diagram

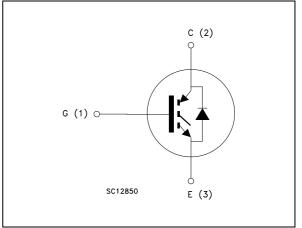


Table 1.Device summary

Order code	Marking	Package	Packaging
STGW50HF60SD GW50HF60SD		TO-247	Tube

1 Electrical ratings

Symbol	Parameter	Value	Unit
V _{CES}	Collector-emitter voltage ($V_{GE} = 0$)	600	V
I _C ⁽¹⁾	Continuous collector current at $T_C = 25 \ ^{\circ}C$	110	А
I _C ⁽¹⁾	Continuous collector current at $T_C = 100 \text{ °C}$	60	А
I _{CL} ⁽²⁾	Turn-off latching current	60	А
I _{CP} ⁽³⁾	Pulsed collector current	130	А
V_{GE}	Gate-emitter voltage	±20	V
P _{TOT}	Total dissipation at $T_C = 25 \ ^{\circ}C$	284	W
١ _F	Diode RMS forward current at $T_C = 25 \text{ °C}$	30	А
I _{FSM}	Surge non repetitive forward current $t_p = 10 \text{ ms}$ sinusoidal	120	А
Тj	Operating junction temperature	- 55 to 150	°C

1. Calculated according to the iterative formula:

$$I_{C}(T_{C}) = \frac{T_{j(max)} - T_{C}}{R_{thj-c} \times V_{CE(sat)(max)}(T_{j(max)}, I_{C}(T_{C}))}$$

2. Vclamp = 80% of V_{CES}, T_j =150 °C, R_G=10 Ω V_GE=15 V

3. Pulse width limited by maximum junction temperature and turn-off within RBSOA

Table 3.	Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case IGBT	0.44	°C/W
R _{thj-case}	Thermal resistance junction-case diode	1.25	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	50	°C/W



2 Electrical characteristics

(T_J=25°C unless otherwise specified)

Table 4.	Static					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)CES}	Collector-emitter breakdown voltage (V _{GE} = 0)	I _C = 1 mA	600			V
V _{CE(sat)}	Collector-emitter saturation voltage	V_{GE} = 15 V, I _C = 30 A V_{GE} = 15 V, I _C = 30 A, T _J =125 °C		1.15 1.05	1.45	V V
V _{GE(th)}	Gate threshold voltage	V _{CE} = V _{GE} , I _C = 250 μA	3.5		5.7	V
ICES	Collector cut-off current $(V_{GE} = 0)$	V _{CE} =600 V V _{CE} =600 V, T _J =125 °C			50 500	μΑ μΑ
I _{GES}	Gate-emitter leakage current (V _{CE} = 0)	V _{GE} =± 20 V			± 100	nA
9 _{fs}	Forward transconductance	$V_{CE} = 15 V_{,} I_{C} = 30 A$		25		S

Table 4. Static

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{ies} C _{oes} C _{res}	Input capacitance Output capacitance Reverse transfer capacitance	V _{CE} = 25 V, f = 1 MHz, V _{GE} =0	-	4300 400 100	-	pF pF pF
Q _g Q _{ge} Q _{gc}	Total gate charge Gate-emitter charge Gate-collector charge	V _{CE} = 480 V, I _C = 30 A,V _{GE} =15 V	-	200 27 90	-	nC nC nC



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r (di/dt) _{on}	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 400 \text{ V}, I_C = 30 \text{ A}$ $R_G = 10 \Omega, V_{GE} = 15 \text{ V},$ (see Figure 15)	-	50 20 1280	-	ns ns A/µs
t _{d(on)} t _r (di/dt) _{on}	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 400 \text{ V}, I_C = 30 \text{ A}$ $R_G = 10 \Omega, V_{GE} = 15 \text{ V},$ $T_J = 125 \text{ °C} (see Figure 15)$	-	47 22 1100	-	ns ns A/µs
$t_r(V_{off}) \ t_d(_{off}) \ t_f$	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 400 \text{ V}, I_C = 30 \text{ A}$ $R_G = 10 \Omega, V_{GE} = 15 \text{ V},$ <i>(see Figure 15)</i>	-	370 220 465	-	ns ns ns
$t_r(V_{off}) \ t_d(_{off}) \ t_f$	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 400 \text{ V}, I_C = 30 \text{ A}$ $R_G = 10 \Omega, V_{GE} = 15 \text{ V},$ $T_J = 125 \text{ °C} (see Figure 15)$	-	700 250 800	-	ns ns ns

Table 6. Switching on/off (inductive load)

Table 7. Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Eon ⁽¹⁾ E _{off} ⁽²⁾	Turn-on switching losses Turn-off switching losses	$V_{CC} = 400 \text{ V}, I_{C} = 30 \text{ A}$ $R_{G} = 10 \Omega, V_{GF} = 15 \text{ V},$	_	0.25 4.2	_	mJ mJ
E _{ts}	Total switching losses	(see Figure 15)	-	4.45	-	mJ
Eon ⁽¹⁾	Turn-on switching losses	$V_{CC} = 400 \text{ V}, I_C = 30 \text{ A}$		0.45		mJ
E _{off} ⁽²⁾ E _{ts}	Turn-off switching losses Total switching losses	$ R_G = 10 \ \Omega, \ V_{GE} = 15 \ V, $	-	7.8 8.25	-	mJ mJ

 Eon is the turn-on losses when a typical diode is used in the test circuit in *Figure 15*. If the IGBT is offered in a package with a co-pack diode, the co-pack diode is used as external diode. IGBTs and diode are at the same temperature (25°C and 125°C).

2. Turn-off losses include also the tail of the collector current.

Table 8. Collector-emitter diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _F	Forward on-voltage	I _F = 30 A I _F = 30 A, T _J = 125 °C	-	2.8 1.8	-	V V
t _{rr} Q _{rr} I _{rrm}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _F = 30 A, V _R = 50 V, di/dt = 100 A/μs <i>(see Figure 18)</i>	-	67 140 4	-	ns nC A
t _{rr} Q _{rr} I _{rrm}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_F = 30 \text{ A}, V_R = 50 \text{ V},$ $T_J = 125 \text{ °C},$ $di/dt = 100 \text{ A/}\mu\text{s}$ <i>(see Figure 18)</i>	-	103 390 7	-	ns nC A



VCE(sat)

(V)

1.5

1.4

1.3

1.2

1.1

1.0

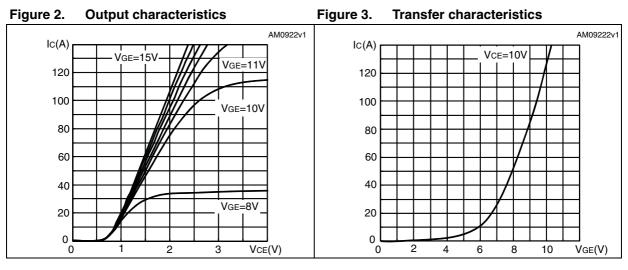
0.9

0.8

57

-50

2.1 Electrical characteristics (curves)



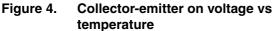
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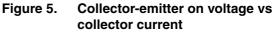
I_C=60A

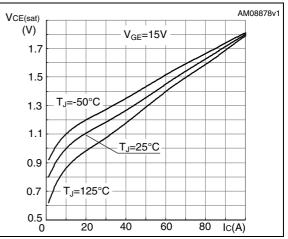
I_C=30A

I_C=15A

TJ(°C)







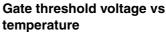


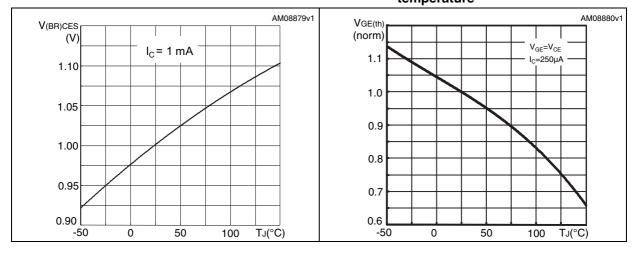
50

0

100

V_{GE}=15V





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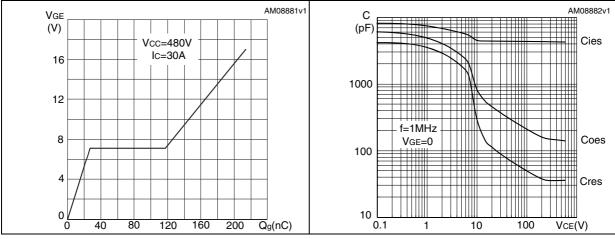


Figure 8. Gate charge vs gate-emitter voltage Figure 9. Capacitance variations

Figure 10. Switching losses vs collector current



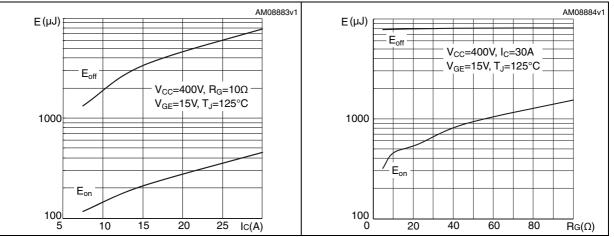


Figure 12. Switching losses vs temperature Figure 13. Turn-off SOA

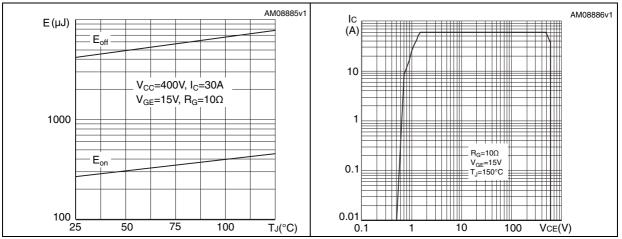
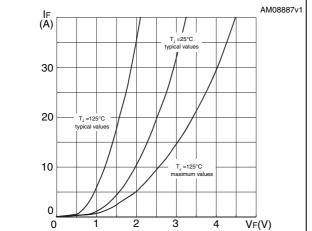




Figure 14. Emitter-collector diode characteristics





3 Test circuits



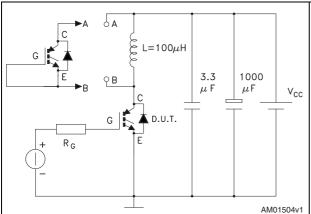
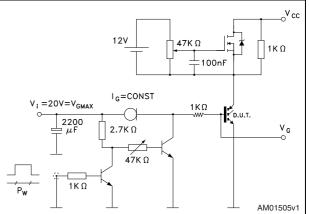
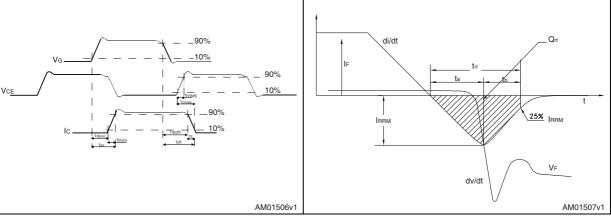


Figure 17. Switching waveform

Figure 16. Gate charge test circuit









4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.



Dim.		mm	
Dini.	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
E	15.45		15.75
е		5.45	
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S		5.50	

Table 9. TO-247 mechanical data



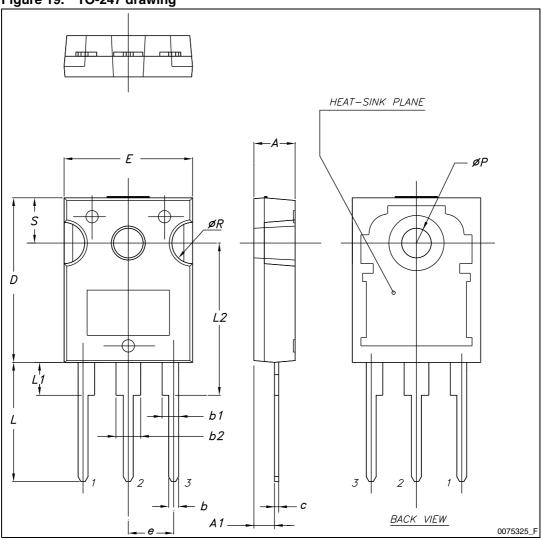


Figure 19. TO-247 drawing



5 Revision history

Table 10. Document revision history

Date	Revision	Changes	
15-Jan-2010	1	Initial release.	
21-Dec-2010	2	Document status promoted to datasheet.	



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